## Application/Control No. Applicant(s)/Patent Under Reexamination 10/724,101 OHMI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1764 Jennifer A. Leung **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY \* US-5,375,652 12-1994 Matsunaga et al. 165/80.3 Α В US-US-С US-D US-Е

## FOREIGN PATENT DOCUMENTS

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